

Notice of References Cited	Application/Control No. 10/563,054		Applicant(s)/Patent Under Reexamination MEIER, MARKUS	
	Examiner Leslie P. Cruz		Art Unit 2826	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,886,408	03-1999	Ohki et al.	257/720
*	B	US-5,371,404	12-1994	Juskey et al.	257/659
*	C	US-2004/0016568 A1	01-2004	Palanisamy, Ponnusamy	174/260
*	D	US-2003/0090873 A1	05-2003	Ohkouchi, Yasuyuki	361/704
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.